Claims:

What I claim are:

- A semiconductor device, comprising

 a substrate with texture on one of its two surfaces, and
 an epitaxial layer comprising an active layer and grown on the top of said texture.
- 2. The semiconductor device of claim 1, further comprising buffer layer grown in between said epitaxial layer and said texture.
- 3. The semiconductor device of claim 1, wherein said texture comprising wells and walls.
- 4. The semiconductor device of claim 3, wherein the width of said walls is in a range of nanometers to micrometers.
- 5. The semiconductor device of claim 3, wherein the depth of said well is in a range of nanometers to micrometers.
- 6. The semiconductor device of claim 3, wherein said wells have the shape of said semiconductor device.
- 7. The semiconductor device of claim 6, wherein the dimension of said wells is in the range of nanometers to micrometers.

- 8. The semiconductor device of claim 1, wherein said substrate emits light.
- 9. A semiconductor device, comprising
 - a substrate with first texture on one of its two surfaces,
 - a first epitaxial layer comprising first active layer and grown on the top of said first texture,
 - a second texture etched on the top surface of said first epitaxial layer, a second epitaxial layer comprising second active layer and grown on the top of said second texture.
- 10. The semiconductor device of claim 9, further comprising first buffer layer grown in between said first epitaxial layer and said first texture of said substrate, and a second buffer layer grown in between said second epitaxial layer and said second texture of said first epitaxial layer.
- 11. The semiconductor device of claim 9, wherein both said first texture and said second texture comprising wells and walls.
- 12. The semiconductor device of claim 11, wherein the width of said walls is in a range of nanometers to micrometers.

- 13. The semiconductor device of claim 11, wherein the depth of said wells is in a range of nanometers to micrometers.
- 14. The semiconductor device of claim 11, wherein said wells have the shape of said semiconductor device.
- 15. The semiconductor device of claim 11, wherein the dimension of said wells is in the range of nanometers to micrometers.
- 16. The semiconductor device of claim 9, wherein said substrate emits light.
- 17.A semiconductor device, comprising
 - a transparent substrate with first texture on one of its two surfaces and second texture on other surface,
 - a first epitaxial layer comprising first active layer and grown on the top of said first texture,
 - a second epitaxial layer comprising second active layer and grown on the top of said second texture.
- 18. The semiconductor device of claim 17, further comprising first buffer layer grown in between said first epitaxial layer and said first texture

- of said substrate, and a second buffer layer grown in between said second epitaxial layer and said second texture of said substrate.
- 19. The semiconductor device of claim 17, wherein both said first texture and said second texture comprising wells and walls.
- 20. The semiconductor device of claim 19, wherein the width of said walls is in a range of nanometers to micrometers.
- 21. The semiconductor device of claim 19, wherein the depth of said wells is in a range of nanometers to micrometers.
- 22. The semiconductor device of claim 19, wherein said wells have the shape of said semiconductor device.
- 23. The semiconductor device of claim 19, wherein the dimension of said wells is in the range of nanometers to micrometers.